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Application/Control No.	Applicant(s)/Patent under Reexamination	•
10/636,037	PENG ET AL.	
Examiner	Art Unit	
Nauven Nao	2616	

SEARCHED			
Class	Subclass	Date	Examiner
370	229	7/26/2007	NHN
370	230	7/26/2007	NHN
370	230.1	7/26/2007	NHN
370	231	7/26/2007	NHN
370	258	7/26/2007	NHN
370	352	7/26/2007	NHN
370	395.4	7/26/2007	NHN
370	395.41	7/26/2007	NHN
370	452	7/26/2007	.NHN
370	459	7/26/2007	NHN
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370	468	7/26/2007	NHN

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Consulted Primary Examiner Steven .Nguyen	7/26/2007	ини
Consulted SPE Firmin Backer	7/26/2007 10/17/07	N4V NHN
PLUS Search Conducted	7/26/2007	NHN
Text Search East see attached	7/26/2007	NHN N/HA